

SCAN921821 Dual 18-Bit Serializer with Pre-emphasis, IEEE 1149.1 (JTAG), and At-Speed BIST

Check for Samples: [SCAN921821](#)

FEATURES

- 15-66 MHz Dual 18:1 Serializer with 2.376 Gbps Total Throughput
- 8-level Selectable Pre-emphasis on Each Channel Drives Lossy Cables and Backplanes
- >15kV HBM ESD Protection on Bus LVDS I/O Pins
- Robust BLVDS Serial Data Transmission with Embedded Clock for Exceptional Noise Immunity and Low EMI
- Power Saving Control Pin for Each Channel
- IEEE 1149.1 "JTAG" Compliant
- At-Speed BIST - PRBS Generation
- No External Coding Required
- Internal PLL, No External PLL Components Required
- Single +3.3V Power Supply
- Low Power: 260 mW (typ) Per Channel at 66 MHz with PRBS-15 Pattern
- Single 3.3 V Supply
- Fabricated with Advanced CMOS Process Technology
- Industrial -40 to +85°C Temperature Range
- Compact 100-ball NFBGA Package

DESCRIPTION

The SCAN921821 is a dual channel 18-bit serializer featuring signal conditioning, boundary SCAN, and at-speed BIST. Each serializer block transforms an 18-bit parallel LVCMOS/LVTTL data bus into a single Bus LVDS data stream with embedded clock. This single serial data stream with embedded clock simplifies PCB design and reduces PCB cost by narrowing data paths that in turn reduce PCB size and layers. The single serial data stream also reduces cable size, the number of connectors, and eliminates clock-to-data and data-to-data skew.

Each channel also has an 8-level selectable pre-emphasis feature that significantly extends performance over lossy interconnect. Each channel also has its own powerdown pin that saves power by reducing supply current when the channel is not being used.

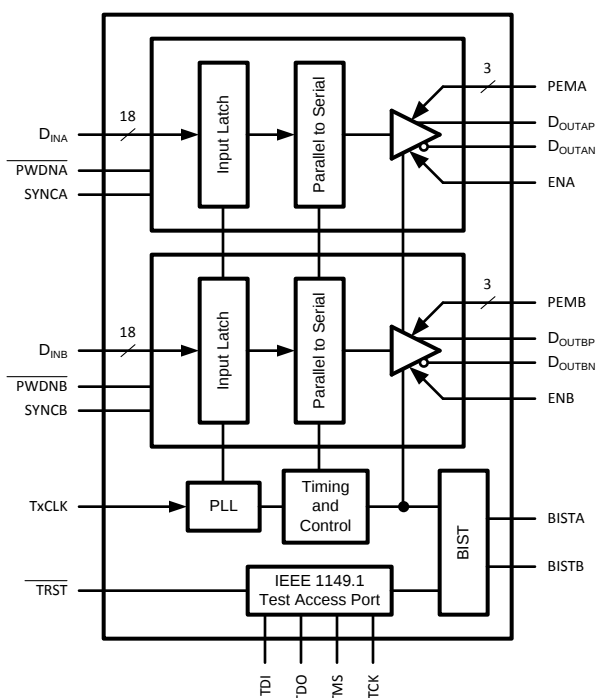
The SCAN921821 also incorporates advanced testability features including IEEE 1149.1 and at-speed BIST PRBS pattern generation to facilitate verification of board and link integrity



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Block Diagram



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings ⁽¹⁾⁽²⁾

Supply Voltage (V _{DD})			-0.3V to +4V
Supply Voltage (V _{DD}) Ramp Rate			< 30 V/ms
LVCMOS/LVTTL Input Voltage			-0.3V to (V _{DD} +0.3V)
LVCMOS/LVTTL Output Voltage			-0.3V to (V _{DD} +0.3V)
Bus LVDS Driver Output Voltage			-0.3V to +3.9V
Bus LVDS Output Short Circuit Duration			10ms
Junction Temperature			+150°C
Storage Temperature			-65°C to +150°C
Lead Temperature (Soldering, 4 seconds)			+220°C
Maximum Package Power Dissipation at 25°C		NFBGA-100	3.57 W
		Derating Above 25°C	28.57 mW/°C
Thermal resistance		θ _{JA}	35°C/W
		θ _{JC}	11.1°C/W
ESD Rating	HBM, 1.5 KΩ, 100 pF	All pins	>8 kV
		Bus LVDS pins	>15 kV
	MM, 0Ω, 200 pF		>1200 V
	CDM		>2 kV

- (1) "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be specified. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" specifies conditions of device operation.
- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.

Recommended Operating Conditions

	Min	Nom	Max	Units
Supply Voltage (V_{DD})	3.15	3.3	3.45	V
Operating Free Air Temperature (T_A)	-40	+25	+85	°C
Clock Rate	15		66	MHz
Supply Noise			100	mV p-p

DC Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified. ⁽¹⁾⁽²⁾

Symbol	Parameter	Conditions	Min	Typ	Max	Units
LVCMOS/LVTTL Input DC Specifications						
V _{IH}	High Level Input Voltage		2.0		V _{DD}	V
V _{IL}	Low Level Input Voltage		GND		0.8	V
V _{CL}	Input Clamp Voltage	I _{CL} = -18 mA	-1.5	-0.7		V
I _{INH}	High Level Input Current	V _{IN} = V _{DD} = V _{DDMAX}	-20	±2	+20	µA
I _{INL}	Low Level Output Current	V _{IN} = V _{SS} , V _{DD} = V _{DDMAX}	-10	±2	+10	µA
1149.1 (JTAG) DC Specifications						
V _{IH}	High Level Input Voltage		2.0		V _{DD}	V
V _{IL}	Low Level Input Voltage		GND		0.8	V
V _{CL}	Input Clamp Voltage	I _{CL} = -18 mA	-1.5	-0.7		V
I _{INH}	High Level Input Current	V _{IN} = V _{DD} = V _{DDMAX}	-20		+20	µA
I _{INL}	Low Level Output Current	V _{IN} = V _{SS} , V _{DD} = V _{DDMAX}	-200		+200	µA
V _{OH}	High Level Output Voltage	I _{OH} = -9 mA	2.3		V _{DD}	mV
V _{OL}	Low Level Output Voltage	I _{OL} = 9 mA	GND		0.5	mV
I _{OS}	Output Short Circuit Current	V _{OUT} = 0 V	-100	-80	-50	mA
I _{OZ}	Output Tri-state Current	$\overline{\text{PWDN}}$ or EN = 0.8V, V _{OUT} = 0 V	-10		+10	µA
		$\overline{\text{PWDN}}$ or EN = 0.8V, V _{OUT} = V _{DD}	-30		+30	µA
Bus LVDS Output DC Specifications						
V _{OD}	Output Differential Voltage (DO+) - (DO-)	See Figure 10, R _L = 100Ω	450	500	550	mV
ΔV _{OD}	Output Differential Voltage Unbalance			2	15	mV
V _{OS}	Offset Voltage		1.05	1.2	1.25	V
ΔV _{OS}	Offset Voltage Unbalance			2.7	15	mV

(1) Typical values are given for $V_{CC} = 3.3\text{V}$ and $T_A = +25^\circ\text{C}$.

(2) Current into device pins is defined as positive. Current out of device pins is defined as negative. Voltages are referenced to ground except V_{OD} , ΔV_{OD} , V_{TH} and V_{TL} which are differential voltages.

DC Electrical Characteristics (continued)

Over recommended operating supply and temperature ranges unless otherwise specified.⁽¹⁾⁽²⁾

Symbol	Parameter	Conditions	Min	Typ	Max	Units	
Q _{POV}	Pre-Emphasis Output Voltage Ratio V _{ODPRE} / V _{OD}	Pre-Emphasis Level = 1	1.10	1.24	1.35		
		Pre-Emphasis Level = 2	1.35	1.47	1.55		
		Pre-Emphasis Level = 3	1.55	1.70	1.80		
		Pre-Emphasis Level = 4	1.80	1.91	1.95		
		Pre-Emphasis Level = 5	1.95	2.08	2.20		
		Pre-Emphasis Level = 6	2.10	2.21	2.35		
		Pre-Emphasis Level = 7	2.15	2.30	2.50		
I _{OS}	Output Short Circuit Current	DO = 0V, Din = H, $\overline{\text{PWDN}}$ and EN = 2.4V	-10	-25	-75	mA	
I _{OZ}	TRI-STATE Output Current	$\overline{\text{PWDN}}$ or EN = 0.8V, DO = 0V ⁽³⁾	-10	± 1	+10	μA	
		$\overline{\text{PWDN}}$ or EN = 0.8V, DO = VDD ⁽³⁾	-55	± 6	+55	μA	
Power Supply Current (DVDD, PVDD and AVDD Pins)							
I _{DD}	Total Supply Current (includes load current)	C _L = 15pF, R _L = 100 Ω	f = 66 MHz, PRBS-15 Pattern		160	225	mA
			f = 66 MHz, Worst Case Pattern (Checker-Board Pattern)		180		mA
I _{DDP}	Total Supply Current with Pre-Emphasis (includes load current)	C _L = 15pF, R _L = 100 Ω	f = 66 MHz, PRBS-15 Pattern		240		mA
			f = 66 MHz, Worst Case Pattern (Checker-Board Pattern)		280	325	mA
I _{DDX}	Supply Current Powerdown	$\overline{\text{PWDN}}$ = 0.8V, EN = 0.8V			1.0	3.0	mA

(3) I_{OZ} is measured at each pin. The DOUT pin not under test is floated to isolate the TRI-STATE current flow.

Timing Requirements for TCLK

Over recommended operating supply and temperature ranges unless otherwise specified.⁽¹⁾⁽²⁾

Symbol	Parameter	Conditions	Min	Typ	Max	Units
t _{TCP}	Transmit Clock Period		15.2	T	66.7	ns
t _{TCIH}	Transmit Clock High Time		0.4T	0.5T	0.6T	ns
t _{TCIL}	Transmit Clock Low Time		0.4T	0.5T	0.6T	ns
t _{CLKT}	TCLK Input Transition Time			3	6	ns
t _{JIT}	TCLK Input Jitter	See ⁽³⁾			80	ps (RMS)

(1) Typical values are given for V_{CC} = 3.3V and T_A = +25°C.

(2) Current into device pins is defined as positive. Current out of device pins is defined as negative. Voltages are referenced to ground except V_{OD}, ΔV_{OD}, V_{TH} and V_{TL} which are differential voltages.

(3) Specified by design using statistical analysis.

AC Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified. ⁽¹⁾⁽²⁾

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Serializer AC Specifications						
t _{LLHT}	Bus LVDS Low-to-High Transition Time	See Figure 2, ⁽³⁾ R _L = 100Ω, C _L =10pF to GND		0.3	0.4	ns
t _{LHLT}	Bus LVDS High-to-Low Transition Time			0.3	0.4	ns
t _{DIS}	DIN (0-17) Setup to TCLK	See Figure 4, ⁽³⁾ R _L = 100Ω, C _L =10pF to GND	1.9			ns
t _{DIH}	DIN (0-17) Hold from TCLK		0.6			ns
t _{HZD}	DO ± HIGH to TRI-STATE Delay	See Figure 5 R _L = 100Ω, C _L =10pF to GND		3.9	10	ns
t _{LZD}	DO ± LOW to TRI-STATE Delay			3.5	10	ns
t _{ZHD}	DO ± TRI-STATE to HIGH Delay			3.2	10	ns
t _{ZLD}	DO ± TRI-STATE to LOW Delay			2.4	10	ns
t _{SPW}	SYNC Pulse Width	See Figure 7, R _L = 100Ω	5*t _{TCP}		6*t _{TCP}	ns
t _{PLD}	Serializer PLL Lock Time	See Figure 6, R _L = 100Ω	510*t _{TCP}		1024*t _{TCP}	ns
t _{SD}	Serializer Delay	See Figure 8 , R _L = 100Ω	t _{TCP} + 2.5	t _{TCP} + 4.5	t _{TCP} + 6.5	ns
t _{SKCC}	Channel to Channel Skew			70		ps
t _{RJIT}	Random Jitter	Room Temperature, V _{DD} = 3.3V, 66 MHz		6.1		ps (RMS)
t _{DJIT}	Deterministic Jitter Figure 9, ⁽³⁾	15 MHz	-390		320	ps
		66 MHz	-60		30	ps
1149.1 (JTAG) AC Specifications						
f _{MAX}	Maximum TCK Clock Frequency	C _L = 15pF, R _L = 500 Ω	25			MHz
t _S	TDI or TMS Setup to TCK, H or L		2.4			ns
t _H	TDI or TMS Hold from TCK, H or L		2.8			ns
t _{W1}	TCK Pulse Width, H or L		10			ns
t _{W2}	$\overline{\text{TRST}}$ Pulse Width, L		10			ns
t _{REC}	Recovery Time, $\overline{\text{TRST}}$ to TCK		2			ns

(1) Typical values are given for $V_{CC} = 3.3\text{V}$ and $T_A = +25^\circ\text{C}$.

(2) Current into device pins is defined as positive. Current out of device pins is defined as negative. Voltages are referenced to ground except VOD, ΔVOD , VTH and VTL which are differential voltages.

(3) Specified by design using statistical analysis.

AC Timing Diagrams and Test Circuits

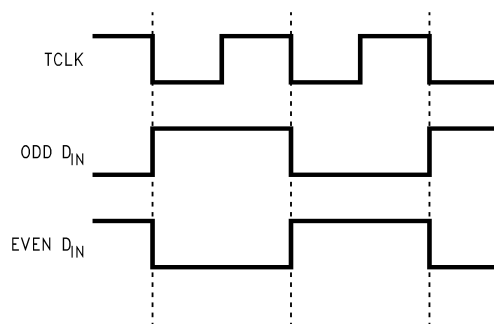


Figure 1. "Worst Case" Serializer IDD Test Pattern

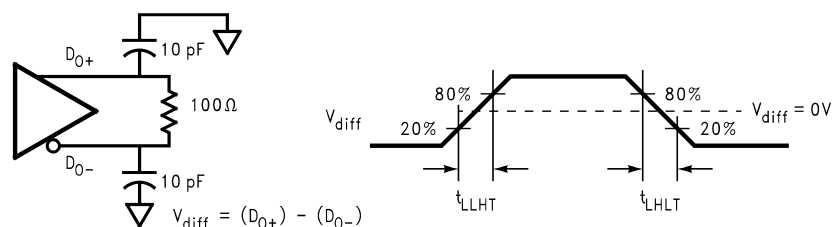


Figure 2. Serializer Bus LVDS Distributed Output Load and Transition Times

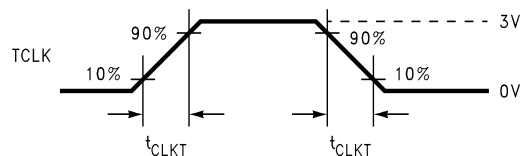


Figure 3. Serializer Input Clock Transition Time

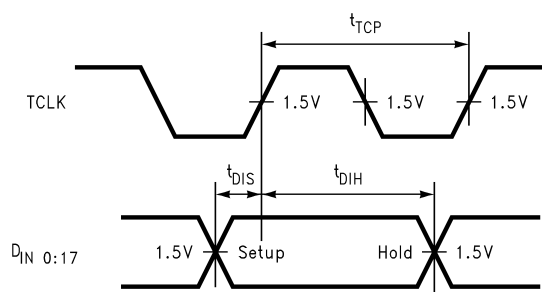


Figure 4. Serializer Setup/Hold Times

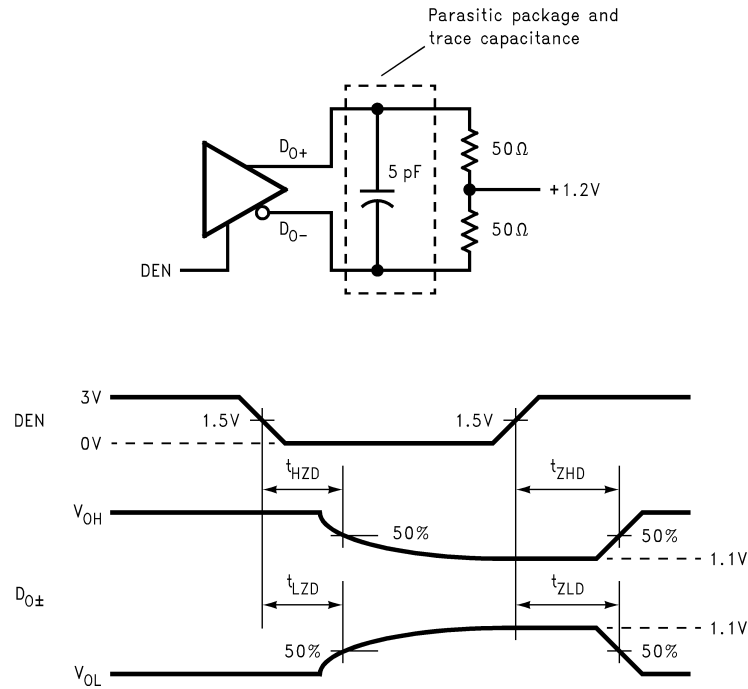


Figure 5. Serializer TRI-STATE Test Circuit and Timing

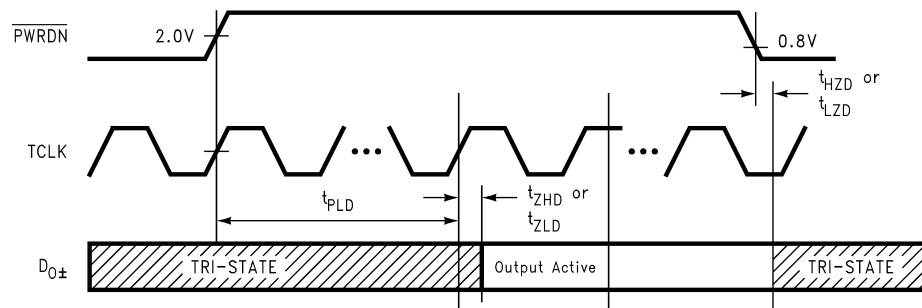


Figure 6. Serializer PLL Lock Time, and $\overline{\text{PWRDN}}$ TRI-STATE Delays

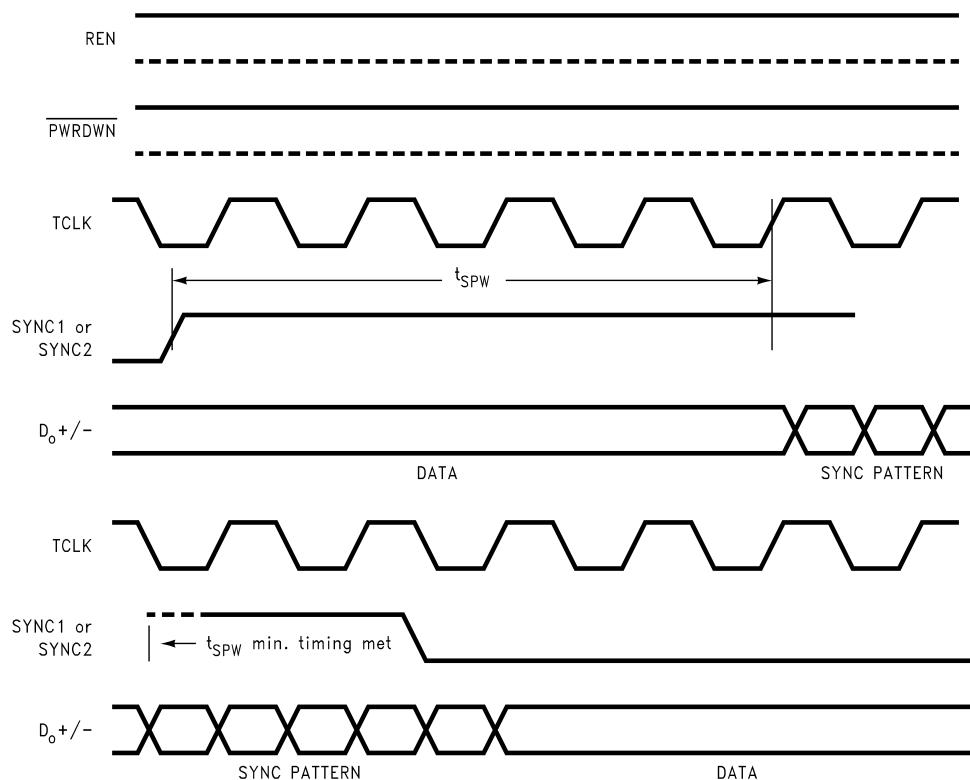


Figure 7. SYNC Timing Delay

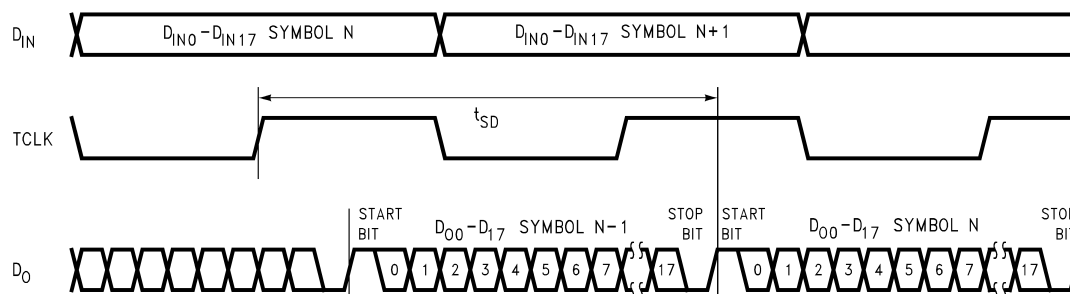


Figure 8. Serializer Delay

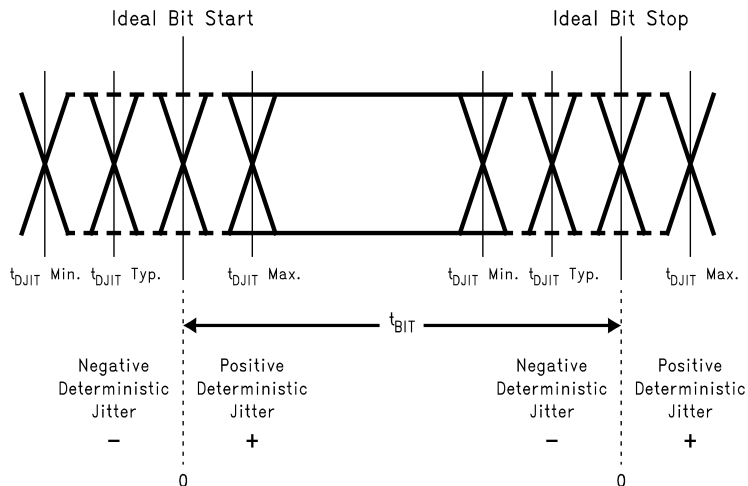
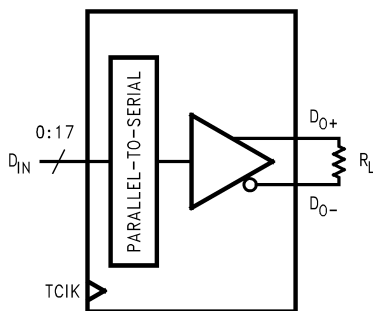


Figure 9. Deterministic Jitter and Ideal Bit Position



$$V_{OD} = (D_O^+) - (D_O^-).$$

Differential output signal is shown as (D_O+)–(D_O–), device in Data Transfer mode.

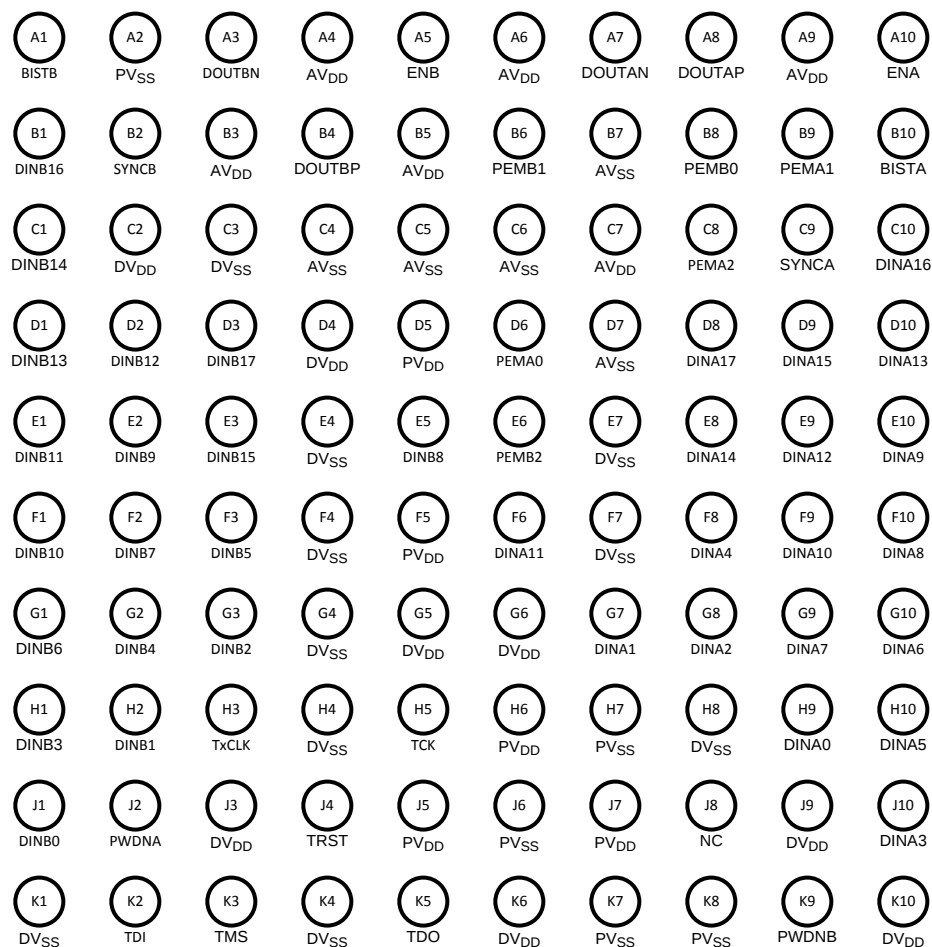
Figure 10. V_{OD} Diagram

Pre-emphasis Truth Table

PEM LEVEL	PEM2	PEM1	PEM0
0	L	L	L
1	L	L	H
2	L	H	L
3	L	H	H
4	H	L	L
5	H	L	H
6	H	H	L
7	H	H	H

Pin Diagram

**Figure 11. SCAN921821TVV
Top View**



Pin Descriptions

Pin Name	Pin Count	I/O, Type	Description
DATA PINS			
DINA0-17	18	I, LVCMOS	Transmitter <u>inputs</u> . There is a pull-down circuitry on each of these pins which are active if respective PWDNA or PWDNB pin is pulled high.
DINB0-17	18		
DOUTAP	1	O,BLVDS	Inverting and non-inverting differential transmitter outputs.
DOUTAN	1		
DOUTBP	1		
DOUTAN	1		
TIMING AND CONTROL PINS			
TxCLK	1	I, LVCMOS	Transmitter reference clock. Used to strobe data at the inputs and to drive the transmitter PLL. There is a pull-up circuitry on this pin which is always active.
ENA	1	I, LVCMOS	Transmitter outputs enable <u>pins</u> . There is a pull-down circuitry on each of these pins that are active if corresponding PWDNA or PWDNB pin is pulled high. When these pins are set to LOW, the transmitter outputs will be disabled. The PLL will remain locked.
ENB	1		
<u>PWDNA</u>	1	I, LVCMOS	Stand-by mode pins. There is a pull-down circuitry on each of these pins that are always active. When these pins are set to LOW, the transmitter will be put in low power mode and the PLL will lose lock.
<u>PWDNB</u>	1		
SYNCA	1	I, LVCMOS	Transmitter synchronization pins. There is a pull-down circuitry on each of these pins that are active if corresponding PWDNA or PWDNB pin is pulled high. When these pins are set to HIGH, the transmitter will ignore incoming data and send SYNC patterns to provide a locking reference to receiver(s).
SYNCB	1		
PRE-EMPHASIS PINS			
PEMA0-2	3	I, LVCMOS	8-level pre-emphasis selection pins. There is a pull-down circuitry on each of these pins which are active if corresponding PWDNA or PWDNB pin is pulled high.
PEMB0-2	3		
JTAG PINS			
TDI	1	I, LVCMOS	Test Data Input to support IEEE 1149.1. There is a pull-up circuitry on this pin which is always active.
TDO	1	O, LVCMOS	Test Data Output to support IEEE 1149.1.
TMS	1	I, LVCMOS	Test Mode Select Input to support IEEE 1149.1. There is a pull-up circuitry on this pin which is always active.
TCK	1	I, LVCMOS	Test Clock Input to support IEEE 1149.1. There is no failsafe circuitry on this pin.
<u>TRST</u>	1	I, LVCMOS	Test Reset Input to support IEEE 1149.1. There is a pull-up circuitry on this pin which is always active.
BIST PINS			
BISTA	1	I, LVCMOS	BIST selection pins. These pins select which transmitter will generate a PRBS like data. There is a pull-down circuitry on these pins which are active if corresponding PWDNA or PWDNB pin is pulled high.
BISTB	1		
POWER PINS			
AVDD	6	I, POWER	Power Supply for the LVDS circuitry.
DVDD	8	I, POWER	Power Supply for the digital circuitry.
PVDD	5	I, POWER	Power Supply for the PLL and BG circuitry.
AVSS	5	I, POWER	Ground reference for the LVDS circuitry.
DVSS	10	I, POWER	Ground reference for the digital circuitry.
PVSS	5	I, POWER	Ground reference for the PLL and BG circuitry.
OTHER PINS			
NC	1	N/A	Not connected.

REVISION HISTORY

Changes from Revision B (April 2013) to Revision C	Page
• Changed layout of National Data Sheet to TI format	11

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
SCAN921821TSM/NOPB	Active	Production	NFBGA (NZD) 100	240 JEDEC TRAY (10+1)	Yes	SNAGCU	Level-4-260C-72 HR	-40 to 85	SCAN921821 TSM
SCAN921821TSM/NOPB.A	Active	Production	NFBGA (NZD) 100	240 JEDEC TRAY (10+1)	Yes	SNAGCU	Level-4-260C-72 HR	-40 to 85	SCAN921821 TSM

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

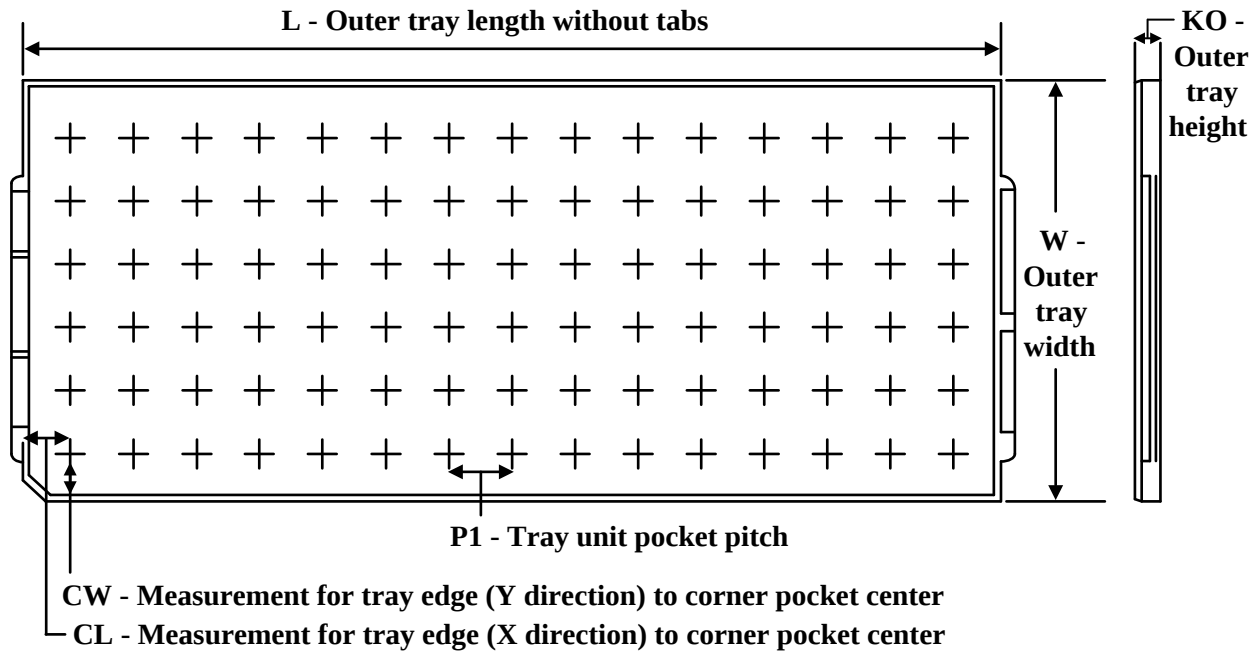
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TRAY

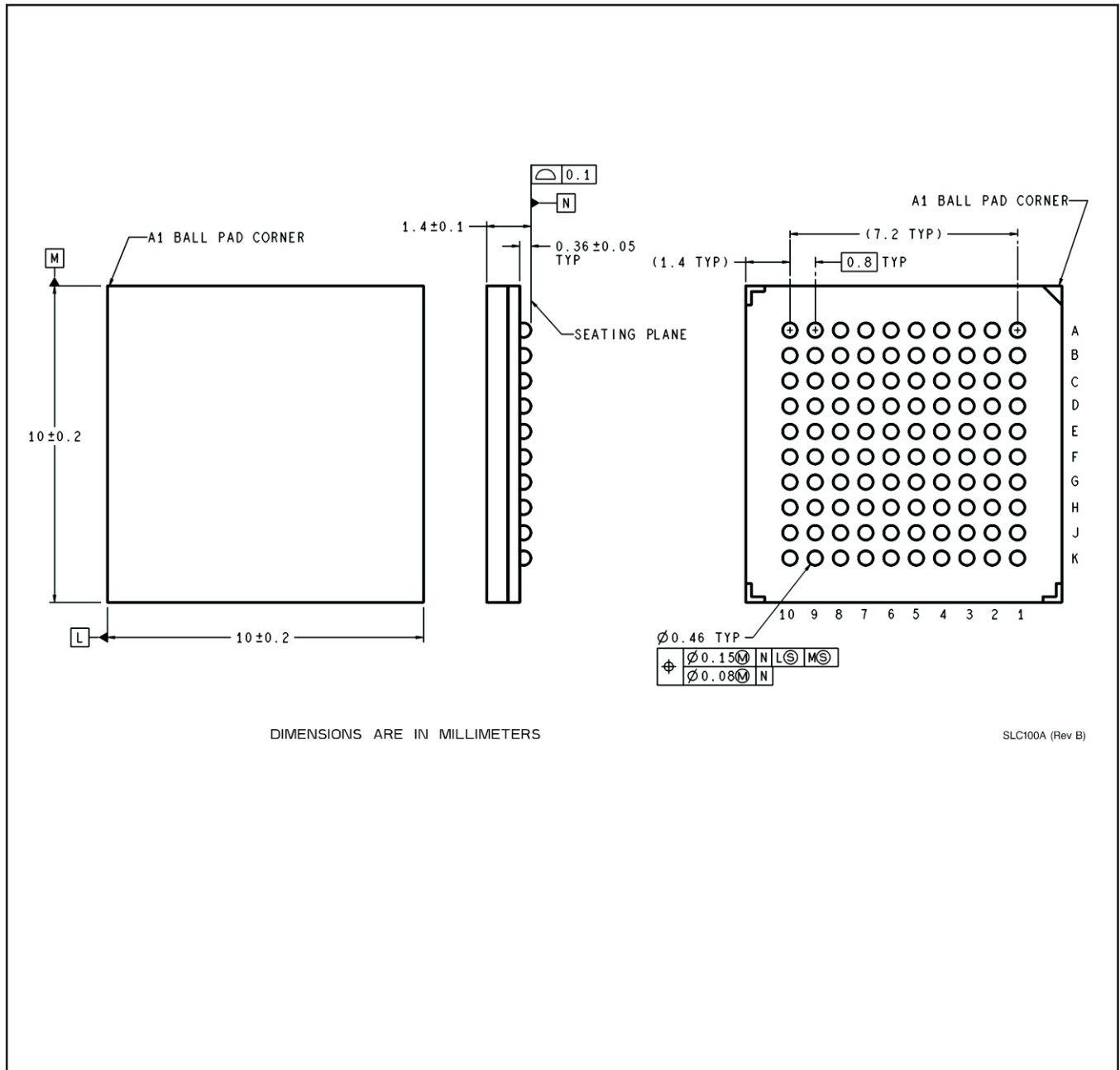


Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	Unit array matrix	Max temperature (°C)	L (mm)	W (mm)	K0 (µm)	P1 (mm)	CL (mm)	CW (mm)
SCAN921821TSM/ NOPB	NZD	NFBGA	100	240	10 X 24	150	322.6	135.9	7620	12.4	14.9	12.15
SCAN921821TSM/ NOPB.A	NZD	NFBGA	100	240	10 X 24	150	322.6	135.9	7620	12.4	14.9	12.15

NZD0100A



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